

Search Notes

Application/Control No.

10/083,510

Examiner

Yixing Qin

Applicant(s)/Patent under
Reexamination

NAKAYAMA ET AL.

Art Unit

2622

SEARCHED

Class	Subclass	Date	Examiner
358	1.18	10/26/2005	YQ

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Performed mostly text searching focusing on print buffers	10/26/2005	YQ